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					FILING DATE November 28, 2001		GROUP 2611		
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Based on Form PTO-1449 ATTY. DOCKET NO. SERIAL NO. 450101-03636 09/996,007 (3/90)**APPLICANT** Satoru MAEDA et al. LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary) GROUP FILING DATE November 28, 2001 2611 U.S. PATENT DOCUMENTS SUBCLASS FILING DATE IF DOCUMENT NUMBER DATE NAME CLASS EXAMINER APPROPRIATE INITIAL 12/16/97 Lawler et al. AA 5 699 107 5 907 323 05/25/99 Lawler et al. AB AC AD JUN 1 6 2004 ΑE Technology Center 2600 AF AG AH ΑI ΑJ AK FOREIGN PATENT DOCUMENTS CLASS SUBCLASS TRANSLATION COUNTRY DOCUMENT NUMBER DATE YES NO EP 0 852 361 07/08/98 Europe AL 10/26/00 PCT WO 00 64150 AM WO 00 46988 08/10/00 PCT AN ΑO ΑP OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.) ΑQ AR DATE CONSIDERED EXAMINER 4-20-06

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